Features

- 3mm Through hole, 5.08mm lens height
- High Brightness
- Water Clear lens
- InGaN / AlInGaP Technology
- Special packaging available upon request
- High reliability

Description

The INL-3AX30 is high brightness 30 degrees through-hole lamp. It is a 3mm epoxy type LED which can be used in various applications.

Applications

- Consumer Electronics
- Variable Message Signs (VMS)
- Automobile After Market
- Industrial Equipment
- Advertising Signs

Package Dimensions in mm

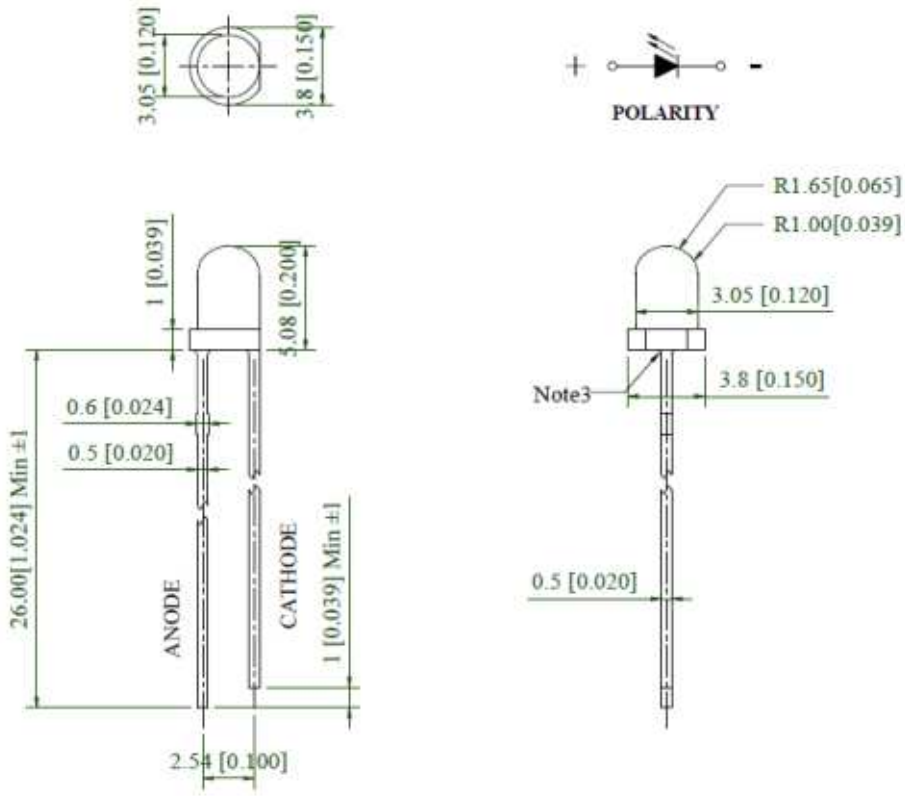


Figure 1. INL-3AX30 Package Dimensions

Absolute Maximum Rating at 25ºC (Note 1)

Product	Emission Color	P_d (mW)	I_F (mA)	I_{FP}* (mA)	V_R (V)	T_{OP} (ºC)	T_{ST} (ºC)
INL-3AYG30	Yellow Green	65	25	100	5	-40°C~+85°C	-40°C~+100°C
INL3AY30	Yellow						
INL3AA30	Amber						
INL3AR30	Red						
INL3AB30	Blue	95	25	100			
INL3AG30	Green						
INL3AW30	White						

Notes
1. Condition for IFP is pulse of 1/10 duty and 0.1msec width

Electrical Characteristics T_A = 25℃ (Note 1)

Product	Emission Color	I_F(mA)	V_F(V)		λ(nm)			Viewing Angle	I^*_V(mcd)	
			min	max	λ_D	λ_P	$\triangle\lambda$	2 θ 1/2	min	typ.
INL-3AYG30	Yellow Green	20	1.6	2.6	573	575	20	30	160	270
INL3AY30	Yellow	20	1.6	2.6	592	590	15	30	270	460
INL3AA30	Amber	20	1.6	2.6	610	605	35	30	270	460
INL3AR30	Red	20	1.6	2.6	632	624	20	30	460	780
INL3AB30	Blue	20	2.6	3.8	470	468	25	30	3800	5000
INL3AG30	Green	20	2.8	3.8	525	520	35	30	11000	18000
INL3AW30	White	20	2.8	3.8	X = 0.28 Y = 0.28			30	5000	8500

Notes

1. Performance guaranteed only under conditions listed in above tables.

ESD Precaution

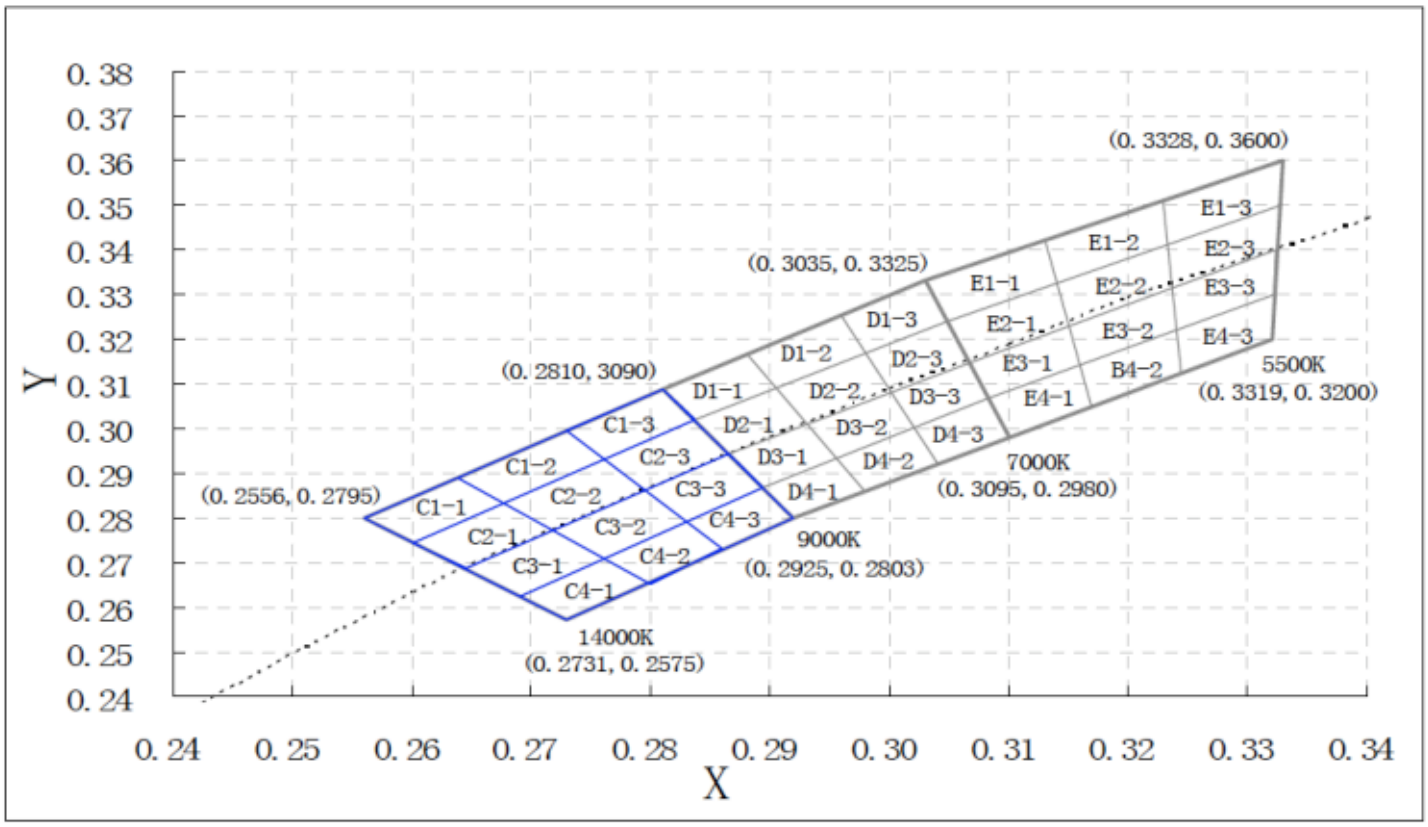
ATTENTION: Electrostatic Discharge (ESD) protection



The symbol above denotes that ESD precaution is needed. ESD protection for GaP and AlGaAs based chips is necessary even though they are relatively safe in the presence of low static-electric discharge. Parts built with AlInGaP, GaN, or/and InGaN based chips are STATIC SENSITIVE devices. ESD precaution must be taken during design and assembly.
If manual work or processing is needed, please ensure the device is adequately protected from ESD during the process.

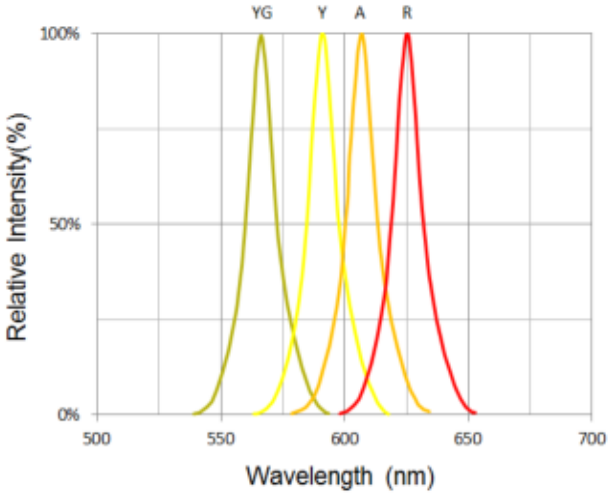
Please be advised that normal static precautions should be taken in the handling and assembly of this device to prevent damage or degradation which may be induced by electrostatic discharge (ESD).

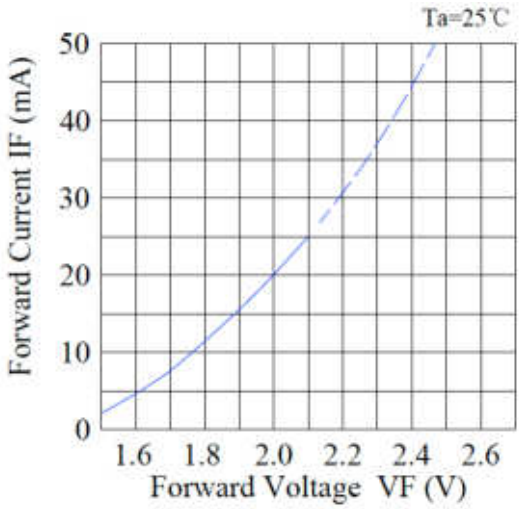
Chromaticity Bin (For White Only)

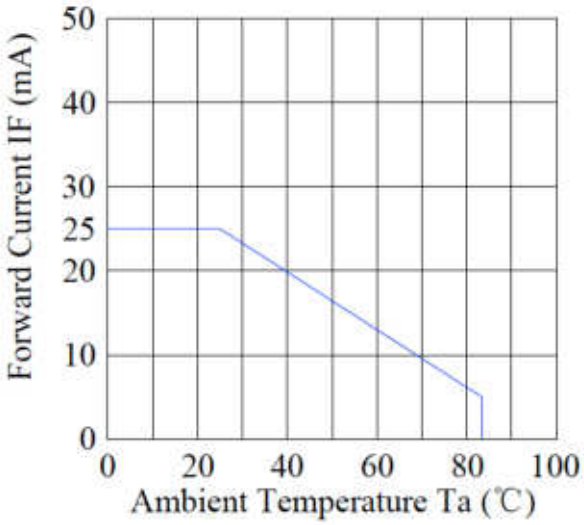


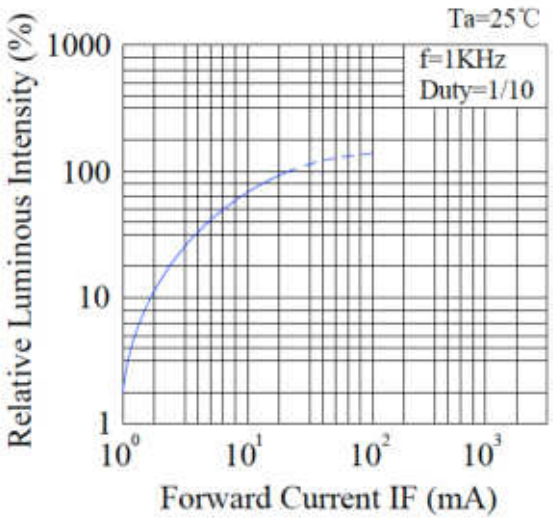
Bin Code	Left x	Left y	Top x	Top y	Right x	Right y	Bottom x	Bottom y
C1-1	0.256	0.28	0.264	0.289	0.268	0.283	0.26	0.274
C2-1	0.26	0.274	0.268	0.283	0.272	0.277	0.264	0.269
C3-1	0.264	0.269	0.272	0.277	0.276	0.271	0.269	0.263
C4-1	0.269	0.263	0.276	0.271	0.28	0.265	0.273	0.257
C1-2	0.264	0.289	0.273	0.299	0.276	0.293	0.268	0.283
C2-2	0.268	0.283	0.276	0.293	0.279	0.286	0.272	0.277
C3-2	0.272	0.277	0.279	0.286	0.283	0.279	0.276	0.271
C4-2	0.276	0.271	0.283	0.279	0.286	0.273	0.28	0.265
C1-3	0.273	0.299	0.281	0.309	0.284	0.302	0.276	0.293
C2-3	0.276	0.293	0.284	0.302	0.287	0.295	0.279	0.286
C3-3	0.279	0.286	0.287	0.295	0.29	0.287	0.283	0.279
C4-3	0.283	0.279	0.29	0.287	0.292	0.28	0.286	0.273
D1-1	0.281	0.309	0.288	0.317	0.291	0.309	0.284	0.302
D2-1	0.284	0.302	0.291	0.309	0.293	0.302	0.287	0.295
D3-1	0.287	0.295	0.293	0.302	0.296	0.294	0.29	0.287
D4-1	0.29	0.287	0.296	0.294	0.298	0.286	0.292	0.28
D1-2	0.288	0.317	0.296	0.325	0.298	0.317	0.291	0.309
D2-2	0.291	0.309	0.298	0.317	0.3	0.308	0.293	0.302
D3-2	0.293	0.302	0.3	0.308	0.302	0.3	0.296	0.294
D4-2	0.296	0.294	0.302	0.3	0.304	0.292	0.298	0.286
D1-3	0.296	0.325	0.303	0.333	0.305	0.324	0.298	0.317
D2-3	0.298	0.317	0.305	0.324	0.307	0.315	0.3	0.308
D3-3	0.3	0.308	0.307	0.315	0.308	0.307	0.302	0.3
D4-3	0.302	0.3	0.308	0.307	0.31	0.298	0.304	0.292
E1-1	0.303	0.333	0.313	0.342	0.314	0.333	0.305	0.324
E2-1	0.305	0.324	0.314	0.333	0.315	0.324	0.307	0.315
E3-1	0.307	0.315	0.315	0.324	0.316	0.314	0.308	0.307
E4-1	0.308	0.307	0.316	0.314	0.317	0.305	0.31	0.298
E1-2	0.313	0.342	0.323	0.351	0.323	0.341	0.314	0.333
E2-2	0.314	0.333	0.323	0.341	0.324	0.332	0.315	0.324
E3-2	0.315	0.324	0.324	0.332	0.324	0.322	0.316	0.314
E4-2	0.316	0.314	0.324	0.322	0.324	0.313	0.317	0.305
E1-3	0.323	0.351	0.333	0.36	0.333	0.35	0.323	0.341
E2-3	0.324	0.332	0.333	0.35	0.332	0.34	0.324	0.331
E3-3	0.324	0.332	0.332	0.34	0.332	0.33	0.324	0.322
E4-3	0.324	0.322	0.332	0.33	0.332	0.32	0.324	0.313

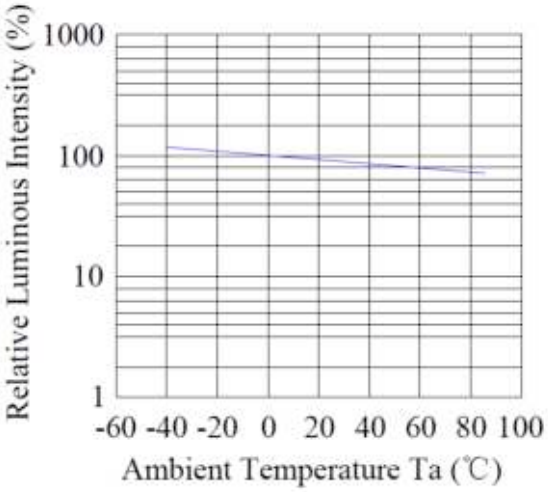
Typical Characteristic Curves – YG, Y, A, R



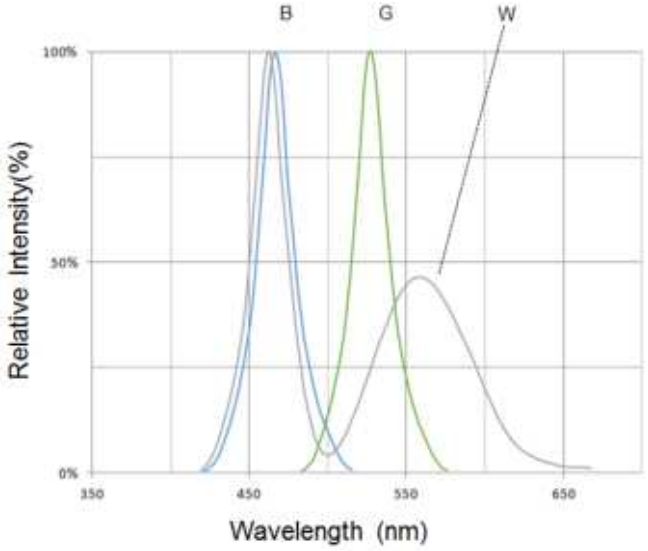


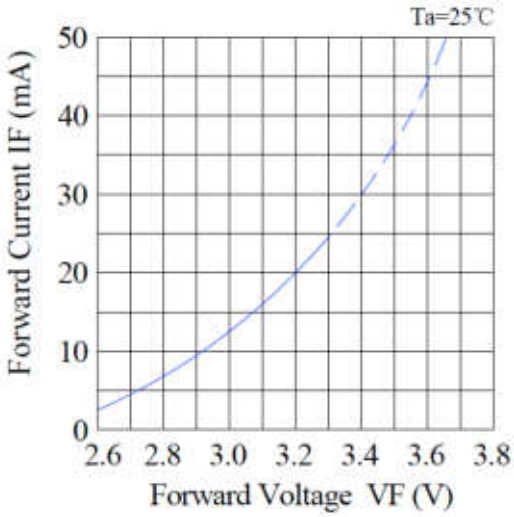


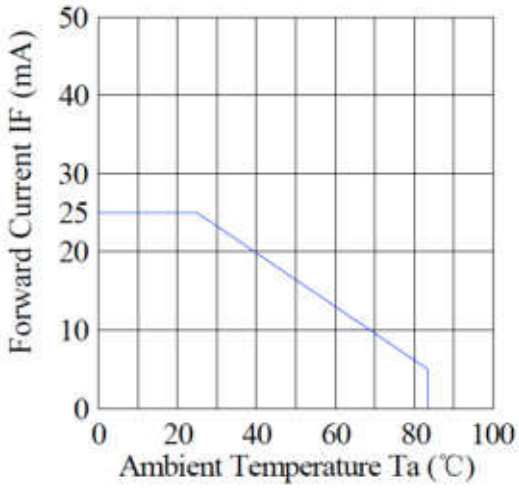


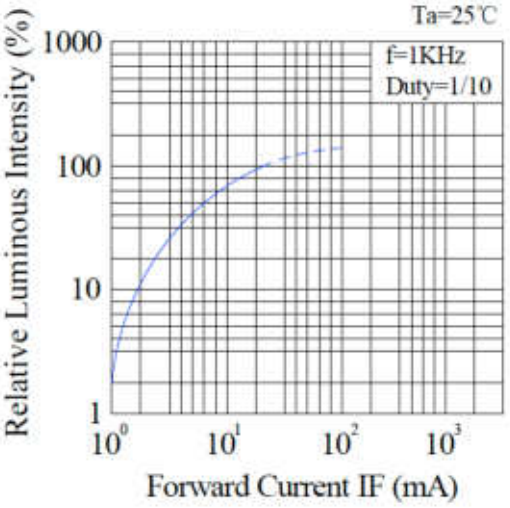


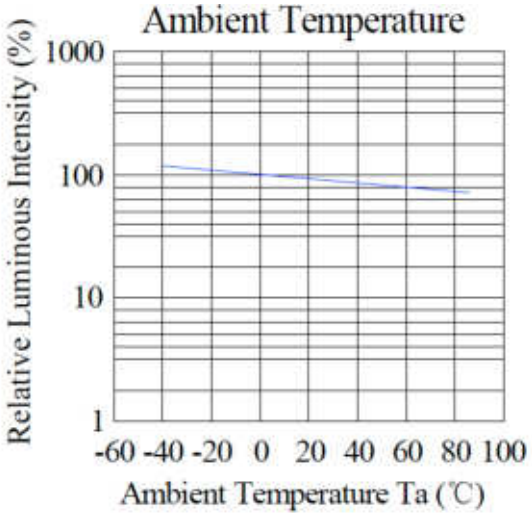
Typical Characteristic Curves – B, G, W



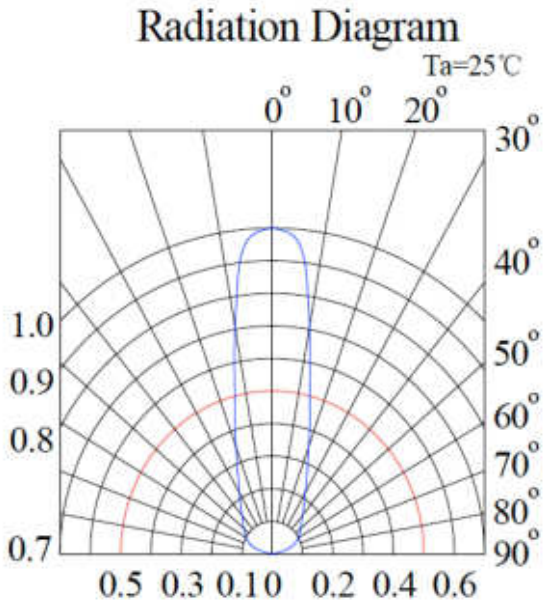








Typical Characteristic Curves – Radiation Pattern



Ordering Information

Product	Emission Color	Technology	Test Current I_F (mA)	Luminous Intensity I_V (mcd) (Typ.)	Forward Voltage V_F (V) (Typ.)	Orderable Part Number
INL-3AYG30	Yellow Green	AlInGaP	20	270	2.0	INL-3AYG30
INL3AY30	Yellow	AlInGaP	20	460	2.0	INL3AY30
INL3AA30	Amber	AlInGaP	20	460	2.0	INL3AA30
INL3AR30	Red	AlInGaP	20	780	2.0	INL3AR30
INL3AB30	Blue	InGaN	20	5000	3.2	INL3AB30
INL3AG30	Green	InGaN	20	18000	3.2	INL3AG30
INL3AW30	White	InGaN	20	8500	3.1	INL3AW30

Label Specifications



Inolux P/N:

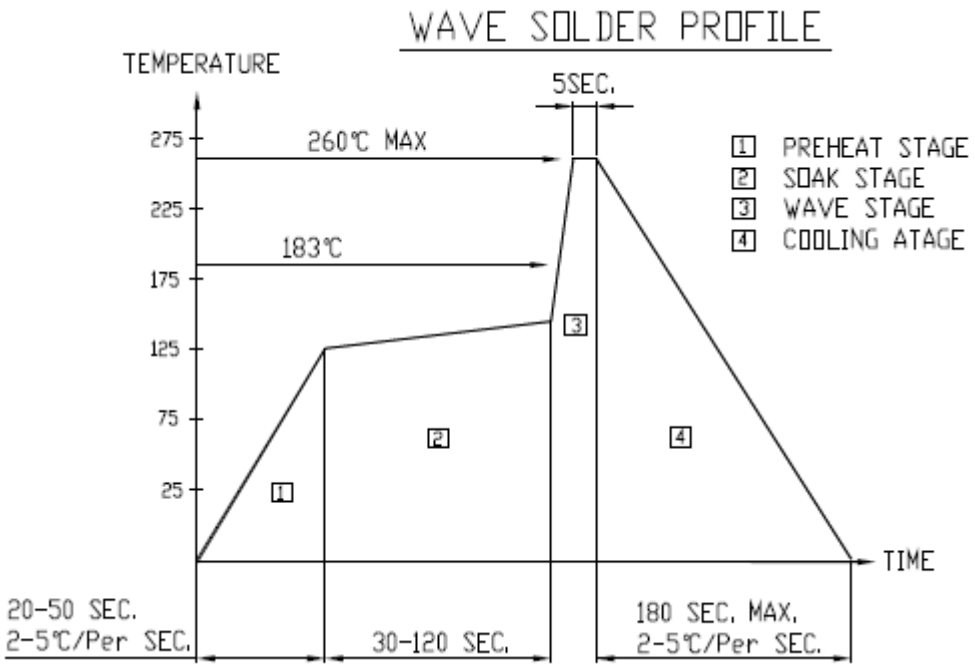
I	N	L	-	3	A		Y	3	0	-	X	X	X	X
				Material		Lens	Color	View Angle			Customized Stamp-off			
Inolux Through Hole Lamp				3A = 3mm with flange, 5.08 height		(Blank) = Clear Lens	R=636nm A=609nm Y=593nm YG=574nm G=530nm B=468nm W=White	30 = 30 deg.						

Lot No.:

Z	2	0	1	7	01	24	001
Internal Tracker	Year (2017, 2018, ...)				Month	Date	Serial

Soldering

Recommended soldering conditions:



Soldering Iron

Basic Spec is Max 3 sec. @ 300°C. Lamps without stopper must leave a min. of 3mm clearance from base of the lens to the soldering point.

Rework

Caution is advised when rework is performed. Rework should be completed within 4 second under 245°C using a double-headed soldering iron.

Reliability

Item	Frequency/ lots/ samples/ failures	Standards Reference	Conditions
Precondition	For all reliability monitoring tests according to JEDEC Level 2	J-STD-020	1.) Baking at 85°C for 24hrs 2.) Moisture storage at 85°C/ 60% R.H. for 168hrs
Solderability	1Q/ 1/ 22/ 0	JESD22-B102-B And CNS-5068	Accelerated aging 155°C/ 24hrs Tinning speed: 2.5+0.5cm/s Tinning: A: 215°C/ 3+1s or B: 260°C/ 10+1s
Resistance to soldering heat		CNS-5067	Dipping soldering terminal only Soldering bath temperature A: 260+/-5°C; 10+/-1s B: 350+/-10°C; 3+/-0.5s
Operating life test	1Q/ 1/ 40/ 0	CNS-11829	1.) Precondition: 85°C baking for 24hrs 85°C/ 60%R.H. for 168hrs 2.) Tamb25°C; IF=20mA; duration 1000hrs
High humidity, high temperature bias	1Q/ 1/ 45/ 0	JESD-A101-B	Tamb: 85°C Humidity: 85% R.H., IF=5mA Duration: 1000hrs
High temperature bias	1Q/ 1/ 20	IN specs.	Tamb: 55°C IF=20mA Duration: 1000hrs
Pulse life test	1Q/ 1/ 40/ 0		Tamb25°C, If=20mA,, Ip=100mA, Duty cycle=0.125 (tp=125 μs,T=1sec) Duration 500hrs)
Temperature cycle	1Q/ 1/ 76/ 0	JESD-A104-A IEC 68-2-14, Nb	A cycle: -40 degree C 15min; +85 degree C 15min Thermal steady within 5 min.. 300 cycles 2 chamber/ Air-to-air type
High humidity storage test	1Q/ 1/ 40/ 0	CNS-6117	60+3°C 90+5/-10% R.H. for 500hrs
High temperature storage test	1Q/ 1/ 40/ 0	CNS-554	100+10°C for 500hrs
Low temperature storage test	1Q/ 1/ 40/ 0	CNS-6118	-40+5°C for 500hrs

Revision History

Changes since last revision	Page	Version No.	Revision Date
Initial Release		1.0	07-10-2017

DISCLAIMER

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2. A critical component in any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.